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## **Lasing Reporting Summary**

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PΙε	ease check: are the following details reported in t	he manu	script?
1.	Threshold		
	Plots of device output power versus pump power over a wide range of values indicating a clear threshold	Yes  No	Not applicable
2.	Linewidth narrowing		
	Plots of spectral power density for the emission at pump powers below, around, and above the lasing threshold, indicating a clear linewidth narrowing at threshold	Yes No	Not applicable
	Resolution of the spectrometer used to make spectral measurements	Yes No	Not applicable
3.	Coherent emission		
	Measurements of the coherence and/or polarization of the emission	Yes No	Not applicable
4.	Beam spatial profile		
	Image and/or measurement of the spatial shape and profile of the emission, showing a well-defined beam above threshold	Yes No	Not applicable
5.	Operating conditions		
	Description of the laser and pumping conditions Continuous-wave, pulsed, temperature of operation	Yes No	Not applicable
	Threshold values provided as density values (e.g. W $\rm cm^{-2}$ or J $\rm cm^{-2}$ ) taking into account the area of the device	Yes No	Not applicable
6.	Alternative explanations		
	Reasoning as to why alternative explanations have been ruled out as responsible for the emission characteristics e.g. amplified spontaneous, directional scattering; modification of fluorescence spectrum by the cavity	Yes  No	Not applicable
7.	Theoretical analysis		
	Theoretical analysis that ensures that the experimental values measured are realistic and reasonable e.g. laser threshold, linewidth, cavity gain-loss, efficiency	Yes  No	Not applicable
8.	Statistics		
	Number of devices fabricated and tested	Yes No	(Not applicable
	Statistical analysis of the device performance and lifetime (time to failure)	Yes No	Not applicable